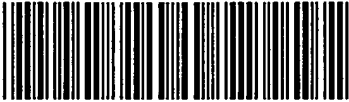
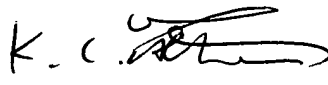
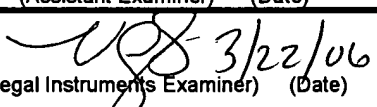


Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/766,710		LEE, HEON	
	Examiner		Art Unit	
	Kin-Chan Chen		1765	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
438		702		216	72				
INTERNATIONAL CLASSIFICATION				430	323				
H	0	1	L	21/311					
				/					
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				/					

(Assistant Examiner) (Date)		 Kin-Chan Chen (Primary Examiner)	Total Claims Allowed: 32	
 (Legal Instruments Examiner) (Date)			O.G. Print Claim(s)	O.G. Print Fig.
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<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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